EVTODIEV, Silvia, CARAMAN, Iu., DMITROGLO, Liliana et al. Optical Properties of III–VI Lamellar Semiconductors Doped with Cu and Cd and of Related III–VI/Native Oxide Structures . In: Journal of Nanoelectronics and Optoelectronics. 2011, Vol. 6, nr. 4, pp. 502-513. ISSN 1555-130X.

GaS, GaSe and GaTe are typical representatives of III–VI layered semiconductor materials, showing highly anisotropic mechanical and optical properties. At photon energies $hv < E_g$, the anisotropy ratio for the absorption coefficients at the n=1 excitonic peak, corresponding to $E^{\rightarrow}C^{\rightarrow}$ and $E^{\rightarrow}\bot C^{\rightarrow}$ polarizations, is α / α $_{\perp}\approx15$. Optical functions $n_e(\lambda)$ and $n_o(\lambda)$ of GaS and GaSe in the wavelength range 0.36–22 μ m have been determined. For the photon energies $hv < E_g^{\text{ind}}$, these correspond to a normal dispersion and can be described by power-law wavelength dependences. By means of FTIR transmission and reflection spectroscopy in the spectral range of 1000–85 cm⁻¹, for plan-parallel plates with thickness between several tens of nanometers and centimeters, the wavenumbers of longitudinal optical v(LO) and transverse optical v(TO) phonons have been determined for GaSe [v $_{\perp}(LO)$ = 254 cm⁻¹, v $_{\perp}(TO)$ = 214 cm⁻¹], GaS [v $_{\perp}(LO)$ = 359 cm⁻¹, v $_{\perp}(TO)$ = 297 cm⁻¹, v (LO) = 336 cm⁻¹], and GaTe [v(LO) = 164 cm⁻¹, v(TO) = 118 cm⁻¹].